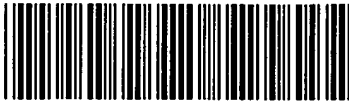


Search Notes

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10/773,784

Examiner

Steve Nguyen

Applicant(s)/Patent under
Reexamination

WHETSEL, LEE D.

Art Unit

2133

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT; USOCR)	5/25/2005	SN